IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Robert Mark Stefan PORTER et al.

International Application No.:   PCT/GB2003/005224

International Filing Date: November 28, 2003

For: VIDEO CAMERA

745 Fifth Avenue
New York, NY 10151

INFORMATION DISCLOSURE STATEMENT

Mail Stop PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Enclosed are copies of the publications, which are cited in the specification and in the UK Search Report of UK Application GB 0227915.6 and the International Search Report of International Application No. PCT/GB2003/005224. Also enclosed is a copy of Form PTO-1449 and the Search Reports.

In the event the above-identified patent application was filed after June 30, 2003 or is an international application that entered the national stage under 35 U.S.C. 371 after June

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /C.C./

30, 2003, no copy of any cited U.S. patent or U.S. patent application publication is provided.

See, "Information Disclosure Statements May Be Filed Without Copies of U.S. Patents and

Published Applications in Patent Applications filed after June 30, 2003" as stated in the Notice

published in The Official Gazette of August 5, 2003.

In the event the above-identified patent application was filed under 35 U.S.C. 111

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after June 30, 2003, no copy of the specification, claims or drawings of any cited pending U.S.

patent application is provided. See, "Waiver of the Copy Requirement in 37 CFR 1.98 for Cited

Pending U.S. Patent Applications" as stated in the Notice published in the Official Gazette of

October 19, 2004.

REMARKS

Entry of this Information Disclosure Statement and an early examination on the

merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

FROMMER LAWRENCE & HAUG LLP
Attorneys for Applicants

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Enclosures

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Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450110-05638	SERIAL NO. 10/537275 Filed Concurrently Herewith
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	APPLICANT Robert Mark Stefan PORTER et al.	
	FILING DATE Filed Concurrently Herewith	GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	2001/0043727	11/22/01	Cooper			
	AB	6, 408, 301	06/18/02	Patton et al.			
	AC	5, 812, 193	09/22/98	Tomitaka et al.			
	AD	2001/0053292	12/20/01	Nakamura			
	AE	2002/0113862	08/22/02	Center, JR. et al.			
	AF	2002/0031262	03/14/02	Imagawa et al.			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AG	WO 00/16243	03/23/00	PCT			
	AH	GB 2 361 097	10/10/01	United Kingdom			
	AI	EP 0 330 455	08/30/89	Europe			
	AJ	WO 99/60788	11/25/99	PCT			
	AK	DE 196 00 958	01/23/97	Germany			
	AL	EP 1 158 786	11/28/01	Europe			
	AM	WO 00/16243	03/23/00	PCT			

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AN		Patent Abstracts of Japan, Publication Number 01273505, Publication Date November 1, 1989
	AO		H. Schneiderman and T. Kanade, " A statistical model for 3D object detection applied to faces and cars," IEEE Conference on Computer Vision and Pattern Detection, 2000.
	AP		H. Schneiderman and T. Kanade, "Probabilistic modelling of local appearance and spatial relationships for object detection," IEEE Conference on Computer Visioni and Pattern Detection, 1998.
	AQ		H. Schneiderman, "A statistical approach to 3D object detection applied to faces and cars," PhD thesis, Robotics Institute, Carnegie Mellon University, 2000.
	AR		E. Hjelmas and B.K. Low, "Face Detection: A Survey," Computer Vision and Image Understanding, no. 83, pp. 236-274, 2001
	AS		M.-H. Yang, D. Kriegman and N. Ahuja, "Detecting Faces in Images: A Survey,"IEEE Trans. on Pattern Analysis and Machine Intelligence, vol. 24, no. 1, pp. 34-58, Jan 2002

EXAMINER /Chia Wei Chen/	DATE CONSIDERED 12/16/2009

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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